

<b>Notice of References Cited</b>	Application/Control No. 10/669,311	Applicant(s)/Patent Under Reexamination ALLEN, WAYNE J.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0101848 A1	08-2002	Lee et al.	370/349
*	B	US-2002/0159463 A1	10-2002	Wang, Yunsen	370/401
*	C	US-2005/0015387 A1	01-2005	Sassi et al.	707/100
*	D	US-2005/0060418 A1	03-2005	Sorokopud, Gennady	709/230
*	E	US-2005/0086300 A1	04-2005	Yeager et al.	709/204
*	F	US-2005/0204058 A1	09-2005	Philbrick et al.	709/238
*	G	US-2006/0106583 A1	05-2006	Fdida et al.	702/189
*	H	US-7,047,313 B1	05-2006	Broerman, Keith Robert	709/238
*	I	US-7,054,304 B2	05-2006	Wang, Yunsen	370/352
*	J	US-7,054,924 B1	05-2006	Harvey et al.	709/220
*	K	US-7,076,787 B2	07-2006	Cheon et al.	719/321
*	L	US-7,120,790 B1	10-2006	LoPresti, Robert	713/151
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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